SLOVENSKI STANDARD

SIST EN 60194:2006

december 2006

Načrtovanje, izdelava in sestavljanje tiskanih plošč – Izrazi in definicije (IEC 60194:2006)

Printed board design, manufacture and assembly - Terms and definitions (IEC 60194:2006)

iTeh STANDARD PREVIEW (standards.iteh.ai)

<u>SIST EN 60194:2006</u> https://standards.iteh.ai/catalog/standards/sist/df909b49-f84f-4034-8981-0cb3e2a5c347/sist-en-60194-2006

ICS 01.040.31; 31.180

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EUROPEAN STANDARD

EN 60194

NORME EUROPÉENNE EUROPÄISCHE NORM

July 2006

ICS 31.180; 31.190

English version

Printed board design, manufacture and assembly - Terms and definitions

(IEC 60194:2006)

Conception, fabrication et assemblage des cartes imprimées - Termes et définitions (CEI 60194:2006)

Konstruktion, Herstellung und Bestückung von Leiterplatten -Begriffe und Definitionen (IEC 60194:2006)

This European Standard was approved by CENELEC on 2006-06-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

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CENELEC

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

Foreword

The text of the International Standard IEC 60194:2006, prepared by IEC TC 91, Electronics assembly technology, was submitted to the Unique Acceptance Procedure and was approved by CENELEC as EN 60194 on 2006-06-01 without any modification.

This European Standard should be used in conjunction with IEC 60050-541 which provides for basic technical terms for board assembly technology not included in this standard.

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 2007-06-01

 latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2009-06-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 60194:2006 was approved by CENELEC as a European Standard without any modification.

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Annex ZA (normative)

- 3 -

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60050-541	_1)	International electrotechnical vocabulary - Chapter 541: Printed circuits	-	-

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¹⁾ Undated reference.

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INTERNATIONAL STANDARD

IEC 60194

Fifth edition 2006-02

Printed board design, manufacture and assembly – Terms and definitions

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PRICE CODE



INTERNATIONAL ELECTROTECHNICAL COMMISSION

PRINTED BOARD DESIGN, MANUFACTURE AND ASSEMBLY – TERMS AND DEFINITIONS

FOREWORD

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International Standard IEC 60194 has been prepared by IEC technical committee 91: Electronics assembly technology.

This fifth edition cancels and replaces the fourth edition (1999) and constitutes a technical revision.

The major change with regard to the previous edition concerns the addition of some four hundred new terms necessary to industry, added as a result of considerable development in assembly technology in recent years.

The text of this standard is based on the following documents:

FDIS	Report on voting	
91/566/FDIS	91/578/RVD	

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

IEC 60194 should be read in conjunction with IEC 60050(541) which provides for basic technical terms for board assembly technology not included in this standard.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed,
- withdrawn,
- · replaced by a revised edition, or
- amended.

A bilingual version of this standard may be issued at a later date.

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PRINTED BOARD DESIGN, MANUFACTURE AND ASSEMBLY – TERMS AND DEFINITIONS

1 Scope

This International Standard defines the terminology used in the field of printed circuit boards and printed circuit board assembly products.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050(541), International Electrotechnical Vocabulary (IEV) – Chapter 541: Printed circuits

3 General

The terms have been classified according to the decimal classification code (DCC) and this DCC number appears to the right of the defined term. The DCC numbering is explained fully in Annex A.

In order to avoid two ID numbers, the usual practice of numbering every paragraph (every term and definition) in front of the paragraph has not been followed in this standard. The official IEC number is the number which follows the DCC and the period (21.xxxx). Annex B provides a list of acronyms listed numerically according to the DCC number.

4 Terms and definitions

Abrasion Resistance 54.1821

The ability of a material to withstand surface wear.

Abrasive Trimming 54.1318

Adjusting the value of a film component by notching it with a finely- adjusted stream of an abrasive material against the resistor surface.

Absorption Coefficients 40.1727

The degree to which various materials absorb heat or radiant energy when compared to each other.

Absorptivity, Infra-red 40.0087

The ratio (or percentage) of the amount of energy absorbed by a substrate as compared with the total amount of incident energy.

Teh STANDAR

Accelerated Aging 93.0001

A test in which the parameters such as rds. voltage and temperature are increased above normal operating values to obtain 60194 observable or measurable deterioration in attandards relatively short period of time.

Accelerated Life Test 93.0119 See "Accelerated Aging".

Accelerated Test 93.0216

A test to check the life expectancy of an electronic component or electronic assembly in a short period of time by applying physically severe condition(s) to the unit under test.

Accelerator 53.0002 See "Catalyst".

Acceleration Factor (AF) 93.0260 The ratio of stress in reliability testing to the normal operating condition.

Acceptance Quality Level (AQL) 90.0003 The maximum number of defectives likely to exist within a population (lot) that can be considered to be contractually tolerable; normally associated with statistically derived

sampling plans.

Acceptance Tests

92.0004

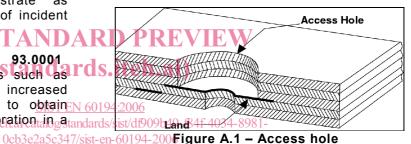
Those tests deemed necessary to determine the acceptability of a product and as agreed to by both purchaser and vendor.

Acceptance Inspection (Criteria) 92.0288

An inspection that determines conformance of a product to design specifications as the basis for acceptance.

Access Hole 60.1319

A series of holes in successive layers of a multilayer board, each set having their centres on the same axis. These holes provide access to the surface of the land on one of the layers of the board. (See Figure A.1.)



3

Access Protocol 21.0005

An agreed principle for establishing how nodes in a network communicate electronically.

Accordion Contact 36.0006

A type of connector contact that consists of a flat spring formed into a "Z" shape in order to permit high deflection without overstress.

Accuracy 90.0007

The deviation of the measured or observed value from the true value.

Acid Flux 46.0009

A solution of an acid and an inorganic, organic, or water soluble organic flux. (See also "Inorganic Flux," "Organic Flux," and "Water Soluble Organic Flux".)

Acid Number 54.0010

The amount of potassium hydroxide in milligrams that is required to neutralize one gram of an acid medium.

Acid Value

See "Acid Number"

Acid-Core Solder

46.0008

54.1217

Wire solder with a self-contained acid flux.

Actinic Radiation 52.0011

energy that reacts with a photosensitive material in order to produce an image.

Active Desiccant 30.0397

Desiccant that is either fresh (new) or has been baked according to the manufacturer's recommendations to renew desiccant to original specifications.

Activated Rosin Flux 46.0012

A mixture of rosin and small amounts of organic-halide or organic-acid activators. (See also "Synthetic Activated Flux".)

Activating 53.0013

A treatment that renders nonconductive A K material receptive to electroless deposition.

Activating Layer 53.0014

A layer of material that renders ISTAEN 6019 al receptive to to standards.iteh.avcatalog/standards nonconductive material electroless deposition. 0cb3e2a5c347/sist-en-

A substance that improves the ability of a flux to remove surface oxides from the surfaces being joined.

Active Device 30.0016

An electronic component whose basic character changes while operating on an applied signal. (This includes diodes, transistors, thyristors, and integrated circuits are used for the rectification, amplification, switching, etc., of analog or digital circuits in either monolithic or hybrid form.)

Active Metal 36.0017

A metal that has a very high electromotive force.

Active Trimming 54.1321

Adjusting the value of a film circuit element in order to obtain a specified functional output from the circuit while it is electrically activated.

Actual Size

90.0018

53.1322

The measured size.

Additive Process

A Process for obtaining conductive patterns by the selective deposition of conductive material on clad or unclad base material. (See also "Semi-Additive Process" and "Fully-Additive Process".)

Add-On Component

30.0019

Discrete or integrated packaged or chip components that are attached to a film circuit in order to complete the circuit's function.

Adhesion

(Pressure Sensitive Tape) 46.2038 The bond produced by contact between

pressure-sensitive adhesive and a surface.

A substance such as glue or cement used to fasten objects together. In surface mounting, an epoxy adhesive is used to adhere SMDs standards.id the substrate.

Adhesion Failure

The rupture of an adhesive bond such that separation appears to be at the adhesive-adherent interface.

Adhesion Layer

74.0021

The metal layer that adheres a barrier metal to a metal land on the surface of an integrated circuit.

Adhesion Promotion 53.0022

The chemical process of preparing a surface to enhance its ability to be bonded to another surface or to accept an over-plate.

Adhesive Coated Substrate 41.0438

A base material upon which an adhesive coating is applied, for the purpose of retaining the conductive material (either additively applied or attached as foil for subtractive processing), that becomes part of a metal-clad dielectric.

Adhesive-Coated Catalyzed Laminate

41.1320

A base material with a thin polymer coating, that contains a plating catalyst, that is subsequently treated in order to obtain a microporous surface.

Adhesive-Coated Uncatalyzed

Laminate 41.1323

A base material with a thin polymer coating, that does not contain a plating catalyst, that is subsequently treated in order to obtain a microporous surface.

Adhesive Transfer

(Pressure Sensitive Tape) 75.0558

The transfer of adhesive from its normal position on the pressure sensitive tape to the surface to which the tape was attached. either during unwind or removal.

Adsorbed Contaminant

96.0023

A contaminant attracted to the surface of a material that is held captive in the form of a gas, vapour or condensate.

Advanced Statistical Method

A statistical process analysis and control technique that is more-sophisticated and less widely-applicable than basic statistical methods. ileh STAND

The change of a property, e.g. solderability,

with time. (See also "Accelerated Aging") STEN

Alkaline Cleaner

and alkaline salts.

76.0032

All Metal Package 33.0579 A hybrid circuit package made solely of metal, without glass or ceramic.

A material blended from alkali hydroxides

Allowable Temperature

75.0609

The temperature range that an electronic circuit or component can perform its intended functions.

Alloy, Tin Bismuth (Sn-Bi) 45.1947

An alloy that is used as a lead free solder and consisting of tin and bismuth as the main constituents. Sn-Bi58 has a low melting point of 138 °C, but is not widely used because of its brittle properties.

Alloy, Tin Copper (Sn-Cu)

45.1948

An alloy that is used as a lead free solder consisting of tin and copper considered to be applicable for wave or reflow soldering.

Aging

\$90.002521 (S. Alloy) Jin Silver (Sn-Ag)

45.1949

An alloy that is used as a lead free solder and consisting of tin and silver as the main constituents used as a high temperature solder. 2006

Air Contamination https://standards.iteh.ai/catalog/standards

See "Air Pollution"

14.0027

Air Pollution Contamination of the atmosphere with substances that are toxic or otherwise harmful.

Algorithm

11.0849

A set of procedures for the solution of a problem in a series of steps.

Alignment Mark

22.0030

A stylized pattern that is selectively positioned on a substrate material to assist in alignment. (See Figure A.2).





Figure A.2 – Alignment mark

Aliphatic Solvents

76.0031

"Straight chain" solvents, derived from petroleum, of low solvent power.

Alloy, Tin Silver Bismuth

(Sn-Ag-Bi)

45.1950

An alloy that is used as a lead free solder and consisting of tin, silver and bismuth as the main constituents. The Bi in Sn-Ag-Bi alloy reduces the melting temperature. The higher the Bi content is, higher the mechanical strength, but with poorer elongation capability. There is a limit to Bi content.

Alloy, Tin Silver Copper

(Sn-Ag-Cu)

45.1951

An alloy that is used as a lead free solder consisting of tin, silver and copper as the main constituents.

Alloy, Tin Zinc (Sn-Zn)

45.1952

An alloy that is used as a lead free solder and consisting of tin and zinc as the main constituents. Zn09 alloy has the melting point of 199 °C, closest to the melting point of Sn-Pb alloy among lead free solders, which allows soldering work at present soldering temperatures, but tends to form a stable oxide film, causing difficulty in securing a good solder wetting.

Alpha Error 91.0033
The size of a Type I error or the probability of rejecting a hypothesis that is true.

Alphanumerical 25.1729
Pertaining to data that contain the letters of an alphabet, the decimal digits, and may contain control characters, special characters and the space character.

Alpha Particle 35.0612

A He⁴ nucleus generated from a nuclear decay that is capable of generating hole-electron pairs in microelectronic devices and switching cells causing soft errors in some devices.

Alternating Current (ac) 21.1793

A current that varies with time, commonly applied to a power source that switches polarity many times per second, in the shape of a sinusoidal, square, or triangular wave.

Alternative Hypothesis

The supposition that a significant difference are disperse exists between the desired results of two electrical co comparable populations. (See also Hypothesis" and "Statistical Hypothesis and "Statistical Hypothesis" and "S

Alumina Substrate 43.1730
Aluminum oxide used as a ceramic substrate material.

Ambient 29.0034

The surrounding environment coming into contact with the system or component in question.

Amorphous Polymer 40.0035
A polymer with a random and unstructured molecular configuration.

Amplitude, Voltage 21.0036

The magnitude of a voltage as measured with respect to a reference, such as a ground plane.

Analog Circuit 21.0037

An electrical circuit that provides a continuous relationship between its input and output.

Analysis of Variance (ANOVA) 91.0038

The systematic method of statistically evaluating experimental results in order to separate the sources of variation.

Anchoring Spur

An extension of a land on a flexible printed board that extends beneath the coverlayer to assist in holding the land to the base material. (See Figure A.3.)

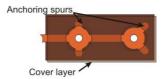


Figure A.3 – Lands with anchoring spurs

Angled Bond 74.0039
The impression of the first and second bonds that are not in a straight line.

Anisotropic Conductive Contact 75.0675

An electrical connection using an anisotropic conductive film or paste wherein conductive particles of gold, silver, nickel, solder, etc. are dispersed. When it is compressed, an electrical connection is attained only in the conductive direction of compression.

Anisotropy 40.0685

The condition for a substance having differing values for properties, such as permittivity, depending on the direction within the material.

Annotation 22.0040
Text, notes, or other identification, constructed by a computer-aided system, intended to be inserted on a drawing, map or diagram.

Annular Ring
(Annular Width) 60.0041
That portion of conductive material completely surrounding a hole. (See Figure A.4).

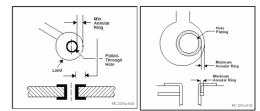


Figure A.4 – Annular ring (annular width)

Anode (BGA)

33.0689

The electrode from which the forward current flows within the device.

Anodic Cleaning

57.0042

Electrolytic cleaning in which the work is the anode.

Aperture (stencil)

73.0690

An opening in the stencil-foil.

92.0043

Apparent Field-of-View Angle The angular subtense of the field-of-view in the image space of an optical system.

Application Specific Integrated Circuit 33.0692

A semiconductor device intended to satisfy a unique complete circuit function.

Aqueous Flux

46.0044

See "Water Soluble Organic Flux"

Artwork

learning.

22.0051

74.0048

73.0758

22.0049

11.0050

An accurately-scaled configuration that is used to produce the "Artwork Master" or Teh ST44.0045 AR "Production Master". (See Figure A.6.)

Area Array Tape Automated

the perimeter of the die.

the area of aperture walls.

Artificial Intelligence

Tape automated Bonding where some carrier tape terminations are made to lands within

The ratio of the area of aperture opening to

A group of elements or circuits arranged in

The capacity of a machine to perform

functions that are normally associated with

human intelligence, such as reasoning and

rows and columns on a base material.

Bondina

Area Ratio

Array

Aramid

See "Para-aramid"

(Standards, Artwork Master

24.0052

45.0054

thick-film

An accurately-scaled, usually 1:1, pattern that is used to produce the "Production Master". (See Figure A.6.)

(values)

components or the smoothness of ceramic

base materials, after they have been processed in a firing furnace and prior to

of

Arc Resistance

92.0047

The resistance of a material to the effects of a high voltage, low current arc (under Master" (sprescribed conditions) passing across the surface of the material. (The resistance is 47/sist-en-As-Fired stated as a measure of total elapsed time at that voltage required to form a conductive path on the surface - material carbonized by the arc).

Architecture

11.0046

The structure of a computer's functional elements that makes it possess specific maximum and minimum capabilities.

Area Array

34.0751

A bonding pattern in which edge and additional pads on the inner surface area of the chip are addressed in the bonding scheme. (See Figure A.5).

0 0 0 0 0

Figure A.5 – Area array

trimming or polishing. Aspect Ratio (Film) 74.0055

condition

The ratio of the length of a film component to its width.

Aspect Ratio (Hole)

53.0056

The ratio of the length or depth of a hole to its preplated diameter. (See Figure A.7.)

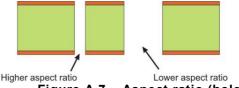


Figure A.7 – Aspect ratio (hole)